

## 1. General description

Planar passivated high commutation three quadrant triac in a ITO3P package intended for use in circuits where high static and dynamic  $dV/dt$  and high  $dI/dt$  can occur. This "series BT" triac will commute the full RMS current at the maximum rated junction temperature ( $T_{j(max)} = 150\text{ °C}$ ) without the aid of a snubber. It is used in applications where "high junction operating temperature capability" is required.

## 2. Features and benefits

- High current TRIAC
- 3Q technology for improved noise immunity
- High commutation capability with maximum false trigger immunity
- High immunity to false turn-on by  $dV/dt$
- High junction operating temperature capability ( $T_{j(max)} = 150\text{ °C}$ )
- High voltage capability
- Least sensitive gate for highest noise immunity
- Low thermal resistance
- Planar passivated for voltage ruggedness and reliability
- Triggering in three quadrants only
- Insulated tab rated at 2500Vrms

## 3. Applications

- High current / high surge applications
- High power / industrial controls - e.g. heating, motors, lighting

## 4. Quick reference data

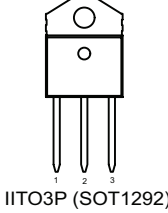
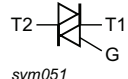
Table 1. Quick reference data

| Symbol       | Parameter                            | Conditions   | Min | Typ | Max | Unit |
|--------------|--------------------------------------|--|-----|-----|-----|------|
| $V_{DRM}$    | repetitive peak off-state voltage    |  | -   | -   | 800 | V    |
| $I_{TSM}$    | non-repetitive peak on-state current | full sine wave; $T_{j(init)} = 25\text{ °C}$ ; $t_p = 20\text{ ms}$ ; <a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a>  | -   | -   | 250 | A    |
| $I_{T(RMS)}$ | RMS on-state current                 | full sine wave; $T_{mb} \leq 121\text{ °C}$ ; <a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a> | -   | -   | 25  | A    |

| Symbol                         | Parameter                             | Conditions   | Min  | Typ | Max | Unit |
|--------------------------------|---------------------------------------|--|------|-----|-----|------|
| <b>Static characteristics</b>  |                                       |  |      |     |     |      |
| I <sub>GT</sub>                | gate trigger current                  | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G+;<br>T <sub>j</sub> = 25 °C; <a href="#">Fig. 7</a>   | -    | -   | 50  | mA   |
|                                |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <a href="#">Fig. 7</a>   | -    | -   | 50  | mA   |
|                                |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G-;<br>T <sub>j</sub> = 25 °C; <a href="#">Fig. 7</a>   | -    | -   | 50  | mA   |
| <b>Dynamic characteristics</b> |                                       |  |      |     |     |      |
| dV <sub>D</sub> /dt            | rate of rise of off-state voltage     | V <sub>DM</sub> = 536 V; T <sub>j</sub> = 150 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit                  | 2000 | -   | -   | V/μs |
| dI <sub>com</sub> /dt          | rate of change of commutating current | V <sub>D</sub> = 400 V; T <sub>j</sub> = 150 °C; I <sub>T(RMS)</sub> = 25 A; dV <sub>com</sub> /dt = 20 V/μs; (snubberless condition); gate open circuit | 15   | -   | -   | A/ms |

## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description             | Simplified outline  | Graphic symbol  |
|-----|--------|-------------------------|---|---|
| 1   | T1     | main terminal 1         |  <p>IITO3P (SOT1292)</p> |  <p>sym051</p> |
| 2   | T2     | main terminal 2         |   |   |
| 3   | G      | gate                    |   |   |
| mb  | n.c.   | mounting base; isolated |   |   |

## 6. Ordering information

Table 3. Ordering information

| Type number   | Package Name | Orderable part number | Packing method | Small packing quantity | Package version | Package issue date |
|---------------|--------------|-----------------------|----------------|------------------------|-----------------|--------------------|
| BTA425Z-800BT | IITO3P       | BTA425Z-800BTQ        | Tube           | 30                     | SOT1292         | 21-Jun-2017        |

## 7. Marking

Table 4. Marking codes

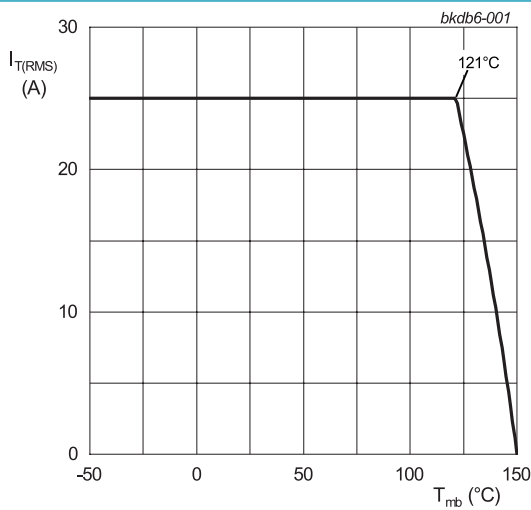
| Type number   | Marking codes    |
|---------------|------------------|
| BTA425Z-800BT | BTA425Z<br>800BT |

## 8. Limiting values

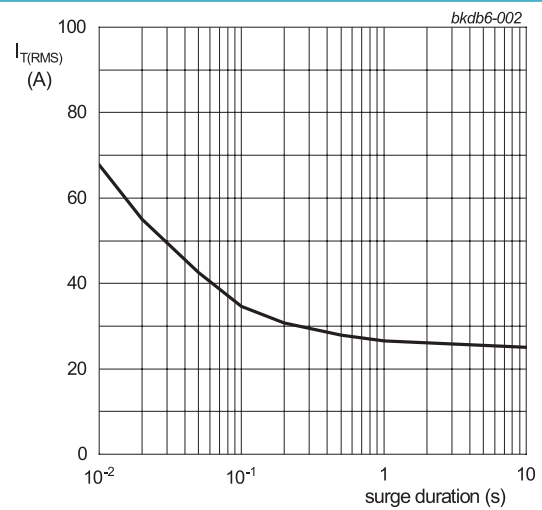
**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

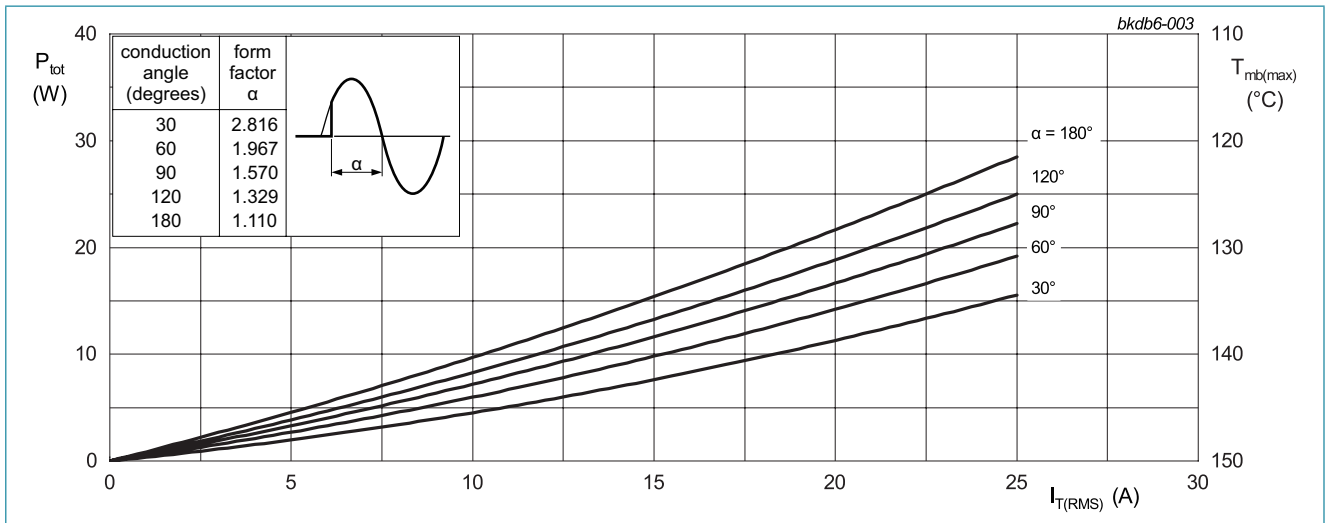
| Symbol       | Parameter                            | Conditions   | Min | Max | Unit             |
|--------------|--------------------------------------|--|-----|-----|------------------|
| $V_{DRM}$    | repetitive peak off-state voltage    |  | -   | 800 | V                |
| $I_{T(RMS)}$ | RMS on-state current                 | full sine wave; $T_{mb} \leq 121\text{ °C}$ ; <a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>     | -   | 25  | A                |
| $I_{TSM}$    | non-repetitive peak on-state current | full sine wave; $T_{j(\text{init})} = 25\text{ °C}$ ; $t_p = 20\text{ ms}$ ; <a href="#">Fig 4</a> ; <a href="#">Fig 5</a> | -   | 250 | A                |
|              |                                      | full sine wave; $T_{j(\text{init})} = 25\text{ °C}$ ; $t_p = 16.7\text{ ms}$   | -   | 275 | A                |
| $I^2t$       | $I^2t$ for fusing                    | $t_p = 10\text{ ms}$ ; SIN   | -   | 340 | A <sup>2</sup> s |
| $di_T/dt$    | rate of rise of on-state current     | $I_G = 0.1\text{ A}$   | -   | 100 | A/ $\mu$ s       |
| $I_{GM}$     | peak gate current                    |  | -   | 4   | A                |
| $P_{GM}$     | peak gate power                      |  | -   | 10  | W                |
| $P_{G(AV)}$  | average gate power                   | over any 20 ms period  | -   | 1   | W                |
| $T_{stg}$    | storage temperature                  |  | -40 | 150 | °C               |
| $T_j$        | junction temperature                 |  | -   | 150 | °C               |



**Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values**

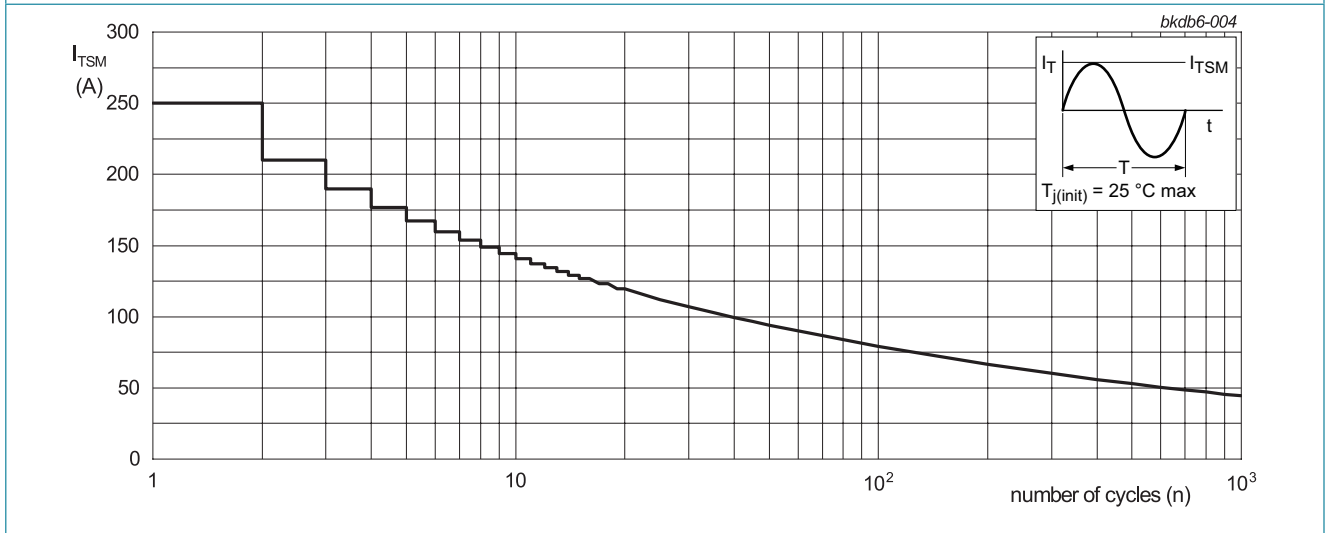


**Fig. 2. RMS on-state current as a function of surge duration; maximum values**  
 $f = 50\text{ Hz}$ ;  $T_{mb} = 121\text{ °C}$



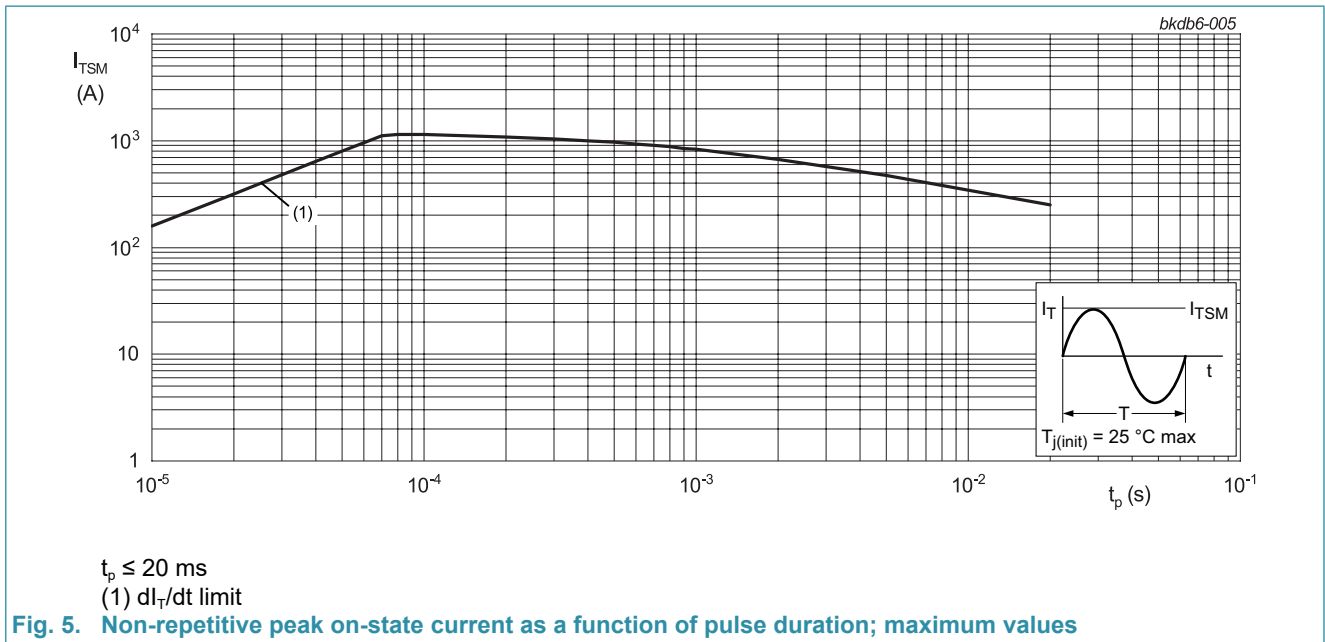
$\alpha$  = conduction angle  
 $a$  = form factor =  $I_{T(RMS)} / I_{T(AV)}$

**Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values**



f = 50 Hz

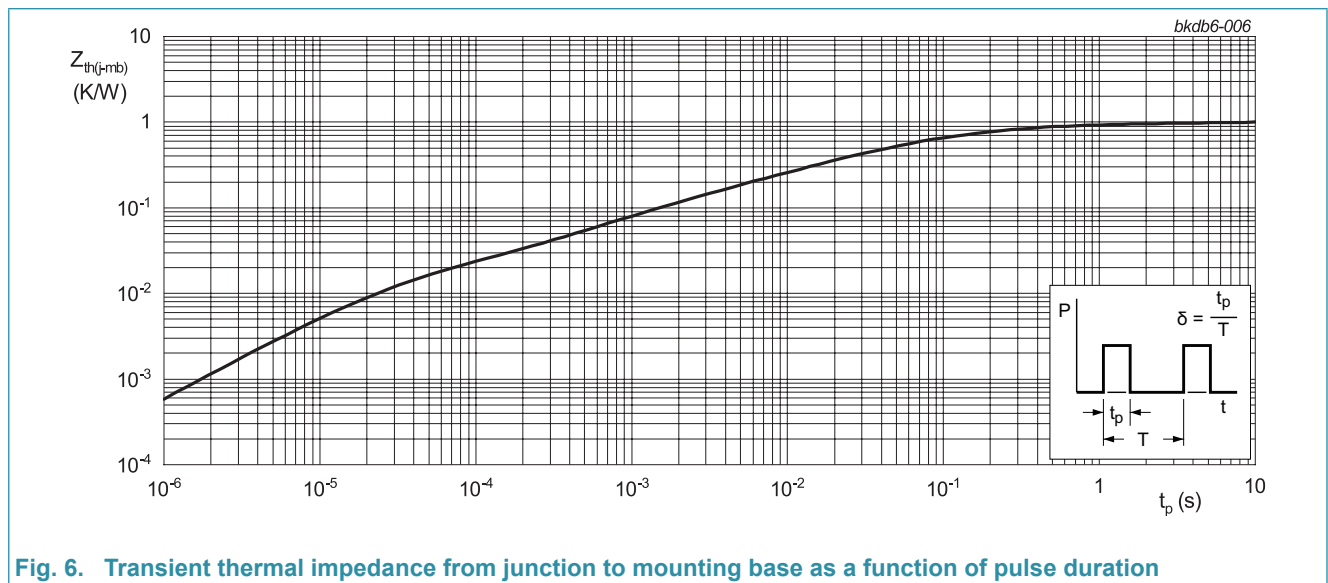
**Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values**



## 9. Thermal characteristics

**Table 6. Thermal characteristics**

| Symbol         | Parameter   | Conditions   | Min | Typ | Max | Unit |
|----------------|---|--|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | full cycle; with heatsink compound; <a href="#">Fig. 6</a> | -   | -   | 1   | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       | in free air  | -   | 50  | -   | K/W  |



**Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration**

## 10. Isolation characteristics

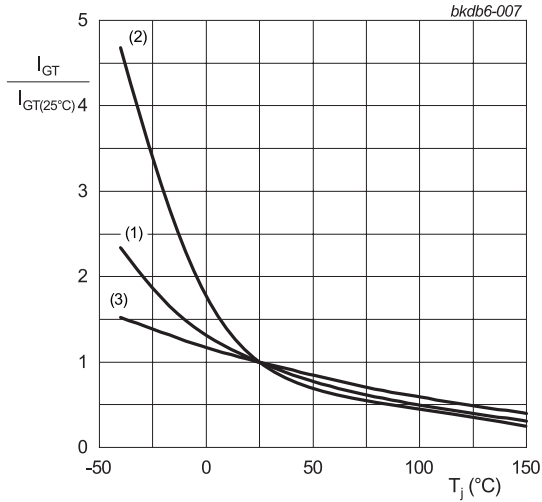
**Table 7. Isolation characteristics**

| Symbol          | Parameter             | Conditions   | Min | Typ | Max  | Unit |
|-----------------|-----------------------|--|-----|-----|------|------|
| $V_{isol(RMS)}$ | RMS isolation voltage | from all terminals to external heatsink; sinusoidal waveform; clean and dust free; $50\text{ Hz} \leq f \leq 60\text{ Hz}$ ; $RH \leq 65\%$ ; $T_h = 25\text{ }^\circ\text{C}$ | -   | -   | 2500 | V    |
| $C_{isol}$      | isolation capacitance | from main terminal 2 to external heatsink; $f = 1\text{ MHz}$ ; $T_h = 25\text{ }^\circ\text{C}$   | -   | 10  | -    | pF   |

## 11. Characteristics

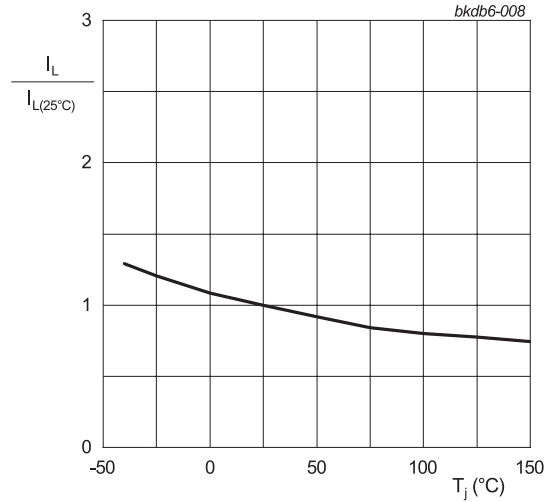
Table 8. Characteristics

| Symbol                         | Parameter                             | Conditions   | Min  | Typ  | Max | Unit             |
|--------------------------------|---------------------------------------|--|------|------|-----|------------------|
| <b>Static characteristics</b>  |                                       |  |      |      |     |                  |
| $I_{GT}$                       | gate trigger current                  | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G+;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 7</a>  | -    | -    | 50  | mA               |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2+ G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 7</a>  | -    | -    | 50  | mA               |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; T2- G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 7</a>  | -    | -    | 50  | mA               |
| $I_L$                          | latching current                      | $V_D = 12\text{ V}$ ; $I_G = 0.1\text{ A}$ ; T2+ G+;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 8</a>  | -    | -    | 80  | mA               |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_G = 0.1\text{ A}$ ; T2+ G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 8</a>  | -    | -    | 100 | mA               |
|                                |                                       | $V_D = 12\text{ V}$ ; $I_G = 0.1\text{ A}$ ; T2- G-;<br>$T_J = 25\text{ °C}$ ; <a href="#">Fig. 8</a>  | -    | -    | 80  | mA               |
| $I_H$                          | holding current                       | $V_D = 12\text{ V}$ ; $T_J = 25\text{ °C}$ ; <a href="#">Fig. 9</a>  | -    | -    | 75  | mA               |
| $V_T$                          | on-state voltage                      | $I_T = 35\text{ A}$ ; $T_J = 25\text{ °C}$ ; <a href="#">Fig. 10</a>   | -    | 1.2  | 1.4 | V                |
| $V_{GT}$                       | gate trigger voltage                  | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_J = 25\text{ °C}$ ;<br><a href="#">Fig. 11</a>   | -    | 0.9  | 1.3 | V                |
|                                |                                       | $V_D = 400\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_J = 150\text{ °C}$  | 0.2  | 0.45 | -   | V                |
| $I_D$                          | off-state current                     | $V_D = 800\text{ V}$ ; $T_J = 25\text{ °C}$  | -    | -    | 5   | $\mu\text{A}$    |
|                                |                                       | $V_D = 800\text{ V}$ ; $T_J = 150\text{ °C}$   | -    | 0.4  | 2   | mA               |
| <b>Dynamic characteristics</b> |                                       |  |      |      |     |                  |
| $dV_D/dt$                      | rate of rise of off-state voltage     | $V_{DM} = 536\text{ V}$ ; $T_J = 150\text{ °C}$ ; ( $V_{DM} = 67\%$ of $V_{DRM}$ ); exponential waveform; gate open circuit                                      | 2000 | -    | -   | V/ $\mu\text{s}$ |
| $dI_{com}/dt$                  | rate of change of commutating current | $V_D = 400\text{ V}$ ; $T_J = 150\text{ °C}$ ; $I_{T(RMS)} = 25\text{ A}$ ; $dV_{com}/dt = 20\text{ V}/\mu\text{s}$ ; (snubberless condition); gate open circuit | 15   | -    | -   | A/ms             |

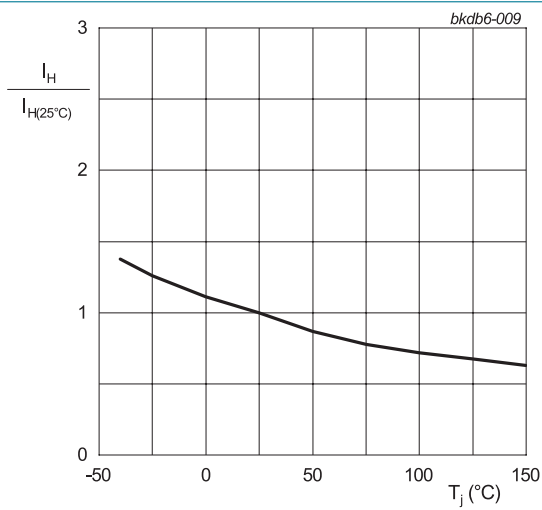


- (1) T2- G-
- (2) T2+ G-
- (3) T2+ G+

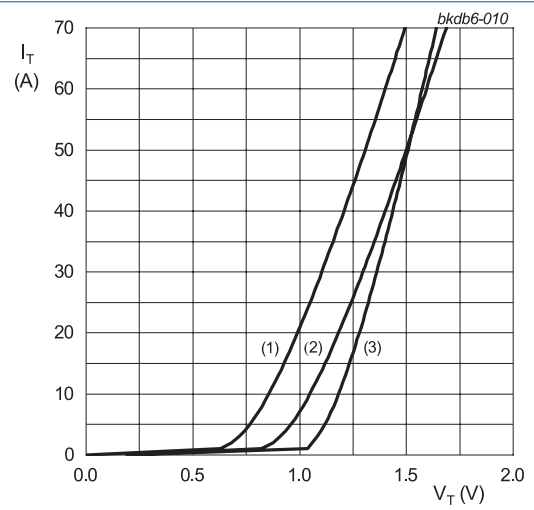
**Fig. 7. Normalized gate trigger current as a function of junction temperature**



**Fig. 8. Normalized latching current as a function of junction temperature**



**Fig. 9. Normalized holding current as a function of junction temperature**



- $V_o = 0.949\text{ V}; R_s = 0.114\ \Omega$   
 (1)  $T_j = 150^\circ\text{C}$ ; typical values  
 (2)  $T_j = 150^\circ\text{C}$ ; maximum values  
 (3)  $T_j = 25^\circ\text{C}$ ; maximum values

**Fig. 10. On-state current as a function of on-state voltage**



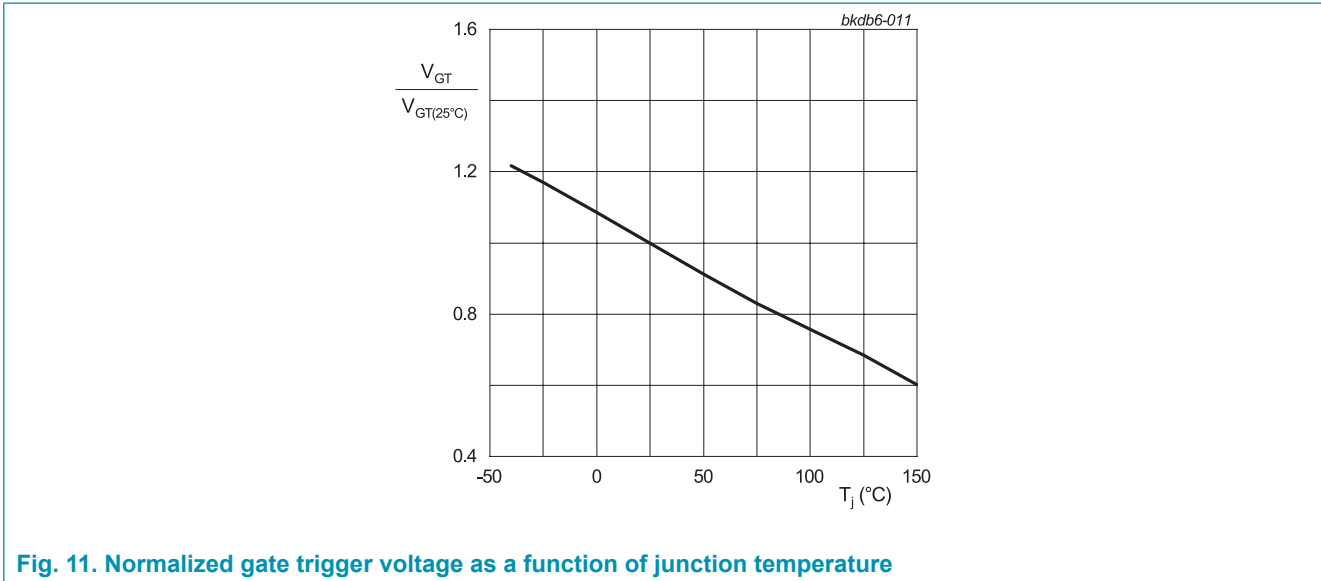
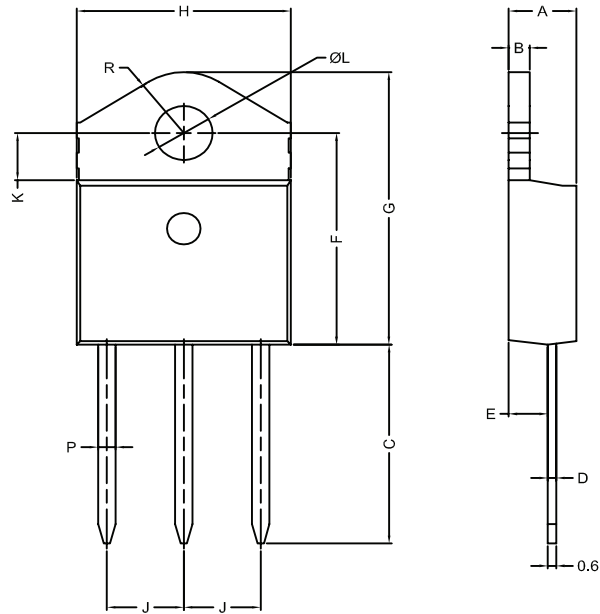


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

## 12. Package outline

Plastic single-ended through-hole package; isolated heatsink mounted; 1 mounting hole; 3-lead TO3P

SOT1292



| Unit |     | A    | B    | C     | D    | E    | F     | G     | H     | J    | K    | L    | P    | R         |
|------|-----|------|------|-------|------|------|-------|-------|-------|------|------|------|------|-----------|
| mm   | min | 4.75 | 1.45 | 14.35 | 0.50 | 2.70 | 15.80 | 20.40 | 15.10 | 5.40 | 3.40 | 4.08 | 1.20 | 4.6       |
|      | max | 4.95 | 1.55 | 15.60 | 0.70 | 2.90 | 16.50 | 21.10 | 15.50 | 5.65 | 3.65 | 4.17 | 1.40 | 4.6 (typ) |

| OUTLINE VERSION | REFERENCES |       |      |  | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|--|---------------------|------------|
|                 | IEC        | JEDEC | EIAJ |  |                     |            |
| SOT1292         |            | -     |      |  |                     |            |

## 13. Legal information

### Data sheet status

| Document status [1][2]         | Product status [3] | Definition  |
|--------------------------------|--------------------|---|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification      | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production         | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.ween-semi.com>.

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For sales office addresses, please send an email to: [salesaddresses@ween-semi.com](mailto:salesaddresses@ween-semi.com)  
Date of release: 07 December 2020

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